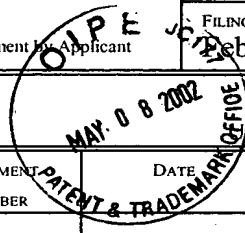


Form PTO 1449  U.S. Department of Commerce Patent and Trademark Office  Information Disclosure Statement by Applicant	ATTY. DOCKET NUMBER	SERIAL NUMBER
	ASAM.0042	10/082,338
	APPLICANT	
	AOKI	
FILING DATE		GROUP
February 26, 2002		2881



**BEST AVAILABLE COPY**

Examiner Initial	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBC LASS	FILING DATE

Foreign Patent Documents


Examiner Initial	DOCUMENT NUMBER	FILING DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	NO
<i>[Signature]</i>	8-330680	5/22/96	Japan			Abstract	X
<i>[Signature]</i>	11-87831	9/2/97	Japan			Abstract	X
<i>[Signature]</i>	2000-68610	3/27/96	Japan			Abstract	X
<i>[Signature]</i>	10-11781	6/19/96	Japan			Abstract	X
<i>[Signature]</i>	6-302003	4/12/93	Japan			Abstract	X
<i>[Signature]</i>	2000-138411	10/29/98	Japan			Abstract	X

Other Documents (Including Author, Title, Date Pertinent Pages, Etc.)

<i>[Signature]</i>	F. Issiki, S. Fukatsu, Y. Shiraki, "Efficient Luminescence from AIP/GaP Neighboring Confinement Structure with AlGaP Barrier Layers", 1995 American Institute of Physics, Appl. Phys. Lett., 67 (8), 21 August 1995, pp. 1048-1050.
<i>[Signature]</i>	N. Usami, F. Issiki, K. Nayak, Y. Shiraki and S. Fukatsu, "Enhancement of Radiative Recombination in Si-based Quantum Wells with Neighboring Confinement Structure", 1995 American Institute of Physics, Appl. Phys. Lett., 67 (4), 24 July 1995, pp. 524-526.

EXAMINER	DATE CONSIDERED
<i>[Signature]</i>	9-03

EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant



Form PTO 1449  U.S. Department of Commerce Patent and Trademark Office  Information Disclosure Statement by Applicant	ATTY. DOCKET NUMBER ASAM.0042  APPLICANT AOKI  FILING DATE February 26, 2002	SERIAL NUMBER 10/082,338  GROUP 2881
--------------------------------------------------------------------------------------------------------------------------------------	---------------------------------------------------------------------------------------------------	--------------------------------------------------

U.S. Patent Documents

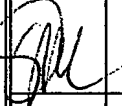
Examiner Initial	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBC LASS	FILING DATE


BEST AVAILABLE COPY

Foreign Patent Documents

Examiner Initial	DOCUMENT NUMBER	FILING DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	NO

Other Documents (Including Author, Title, Date Pertinent Pages, Etc.)

		S. Rennon, K. Avary, F. Klopff, A. Wolf, M. Emmerling, J..P. Reithmaier, A. Forchel, "Edge-emitting microlasers with a single quantum dot active layer", 17 <sup>th</sup> Semiconductor Laser International Conference, technical digest paper THA5, pp. 139-140 <span style="float: right;"><i>no date available</i></span>

EXAMINER 	DATE CONSIDERED 9-03
-------------------------------------------------------------------------------------------------	-------------------------

EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant